Lawrence Berkeley National Laboratory

Recent Work

Title

High-T{sub c} Bolometers

Permalink

https://escholarship.org/uc/item/6rb614pr

Authors

Richards, P.L. Clarke, J. Hu, Q. <u>et al.</u>

Publication Date

1991-06-01

Presented at the Third International Superconductive Electronics Conference '91 (ISEC '91), Glasgow, Scotland, June 25, 1991, and to be published in the Proceedings

High-T_c Bolometers

P.L. Richards, J. Clarke, Q. Hu, R. Leoni, Ph. Lerch, M. Nahum, S. Verghese, M.R. Beasley, T.H. Geballe, R.H. Hammond, P. Rosenthal, S.R. Spielman, K. Char, B.F. Cole, N. Newman, S.A. Sachtjen, and D.K. Fork

June 1991



Materials and Chemical Sciences Division

Lawrence Berkeley Laboratory • University of California

ONE CYCLOTRON ROAD, BERKELEY, CA 94720 • (415) 486-4755

Prepared for the U.S. Department of Energy under Contract DE-AC03-76SF00098

DISCLAIMER

This document was prepared as an account of work sponsored by the United States Government. While this document is believed to contain correct information, neither the United States Government nor any agency thereof, nor the Regents of the University of California, nor any of their employees, makes any warranty, express or implied, or assumes any legal responsibility for the accuracy, completeness, or usefulness of any information, apparatus, product, or process disclosed, or represents that its use would not infringe privately owned rights. Reference herein to any specific commercial product, process, or service by its trade name, trademark, manufacturer, or otherwise, does not necessarily constitute or imply its endorsement, recommendation, or favoring by the United States Government or any agency thereof, or the Regents of the University of California. The views and opinions of authors expressed herein do not necessarily state or reflect those of the United States Government or any agency thereof or the Regents of the University of California.

High-T_c Bolometers

- P.L. Richards, J. Clarke, Qing Hu, R. Leoni, Ph. Lerch, M. Nahum, S. Verghese Department of Physics, University of California, and Materials Sciences Division, Lawrence Berkeley Laboratory, Berkeley, California 94720, U.S.A.
- M.R. Beasley, T.H. Geballe, R.H. Hammond, P. Rosenthal, and S.R. Spielman Department of Applied Physics, Stanford University Stanford, California 94305, U.S.A.

K. Char, B.F. Cole, N. Newman and S.A. Sachtjen Conductus, Inc., Sunnyvale, California 94086, U.S.A.

D.K. Fork, Xerox, Inc., Palo Alto, California 94304 and Department of Applied Physics, Stanford University Stanford, California 94305, U.S.A.

This work was supported in part by the Director, Office of Energy Research, Office of Basic Energy Sciences, Materials Sciences Division of the U.S. Department of Energy under Contract No. DE-AC03-76SF00098.

High-T_c Bolometers

P.L. Richards, J. Clarke, Qing Hu, R. Leoni, Ph. Lerch, M. Nahum, S. Verghese Department of Physics, University of California, and Materials Sciences Division, Lawrence Berkeley Laboratory, Berkeley, California 94720, U.S.A.

M.R. Beasley, T.H. Geballe, R.H. Hammond, P. Rosenthal, and S.R. Spielman Department of Applied Physics, Stanford University Stanford, California 94305, U.S.A.

K. Char, B.F. Cole, N. Newman and S.A. Sachtjen Conductus, Inc., Sunnyvale, California 94086, U.S.A.

D.K. Fork, Xerox, Inc., Palo Alto, California 94304 and Department of Applied Physics, Stanford University Stanford, California 94305, U.S.A.

Abstract. A description is given of recent work on high-T_c superconducting bolometers for infrared and millimeter wavelengths. The first report describes measurements of the thermal boundary resistance between YBCO films and various substrates. This resistance is much larger than expected from the acoustic impedance mismatch model and gives a thermal time constant in the nanosecond range for typical YBCO films. Then, there are reports on the design and experimental performance of two different types of high-T_c bolometric detectors. One is a conventional bolometer with a gold-black absorber. The other is an antenna-coupled microbolometer. Finally, there is a description of the ultimate performance expected from high-T_c bolometers on Si and Si₃N₄ membrane substrates, with comparisons to other detectors used for thermal imaging.

1. <u>Introduction</u>

Many workers have measured the response of high-T_c films (especially YBa₂Cu₃O₇) to infrared radiation. All experiments show one or more types of thermal response when the infrared signal is large. We are designing, fabricating and testing bolometric detectors for infrared and millimeter waves based on this thermal response. We are also exploring relevant physical properties of 123 films such as thermal boundary resistance and noise.

2. Summary

We have made direct measurements of the thermal boundary resistance, R_{bd}, between high quality epitaxial films of YBa₂Cu₃O_{7-δ} and a variety of substrates with and without buffer layers (Nahum et al. 1991(b)). The boundary resistance was deduced from measurements of the electrical resistance changes in three parallel strips of YBa₂Cu₃O_{7-δ} when one was electrically heated. Results are available only for temperatures above the superconducting transition with this method.

Our measurements indicate that R_{bd} is weakly dependent on temperature and, for all the measured samples, has a value of $0.9\text{-}1.4\times10^{\text{-}3}\text{Kcm}^2/\text{W}$ at 100K, which is a factor ~20 larger than the prediction of the acoustic mismatch model. The thermal response of these films to pulsed power is dominated by the heat capacity of the film and the boundary resistance. The resulting thermal response time of ~1ns for typical $YBa_2Cu_3O_7$ - δ films is observed in many experiments with pulsed laser sources.

A design analysis has been given for a bolometric infrared detector that uses the resistive transition of a high-temperature superconductor as the temperature sensing element, and liquid nitrogen as the coolant (Richards et al. (1989)). It was shown that for highly oriented c-axis films, the measured low-frequency noise causes little or no degradation of the performance. With the incoming radiation chopped at 10 Hz, noise equivalent powers (NEP) in the range $(1-20)\times10^{-12}$ W Hz^{-1/2} should be achievable. These values compare favorably with the NEP of other detectors operating at or above liquid nitrogen temperatures for wavelengths greater than 20 μ m.

A sensitive high- T_c superconducting bolometer has been fabricated on a 20 μ m thick sapphire substrate with a YBCO thin film transition edge thermometer (Verghese et al. 1990 and 1991(a)). Optical measurements with a He-Ne laser gave a noise equivalent power of 2.4×10^{-11} W/Hz^{1/2} at 10 Hz and a responsivity of 17 V/W, in good agreement with electrical bolometer measurements. Gold black smoke was then deposited on the back side of the assembled bolometer as an absorber. Spectral measurements on a Fourier transform spectrometer showed that the bolometer has useful sensitivity from visible wavelengths to beyond -100 μ m. This performance is clearly superior to that of a commercial room temperature pyroelectric detector. Some improvement appears possible.

We propose an antenna-coupled microbolometer based on the resistive transition of a high- T_c superconducting film as a detector for far infrared and millimeter waves (Hu and Richards 1989). Such microbolometers can be mechanically stronger, more easily fabricated, and much faster than conventional bolometric infrared detectors. A design analysis shows that a noise equivalent power of 2.5×10^{-12} W Hz^{-1/2} is achievable for modulation frequencies up to 10 kHz. The superconducting film must be of high quality with narrow resistive transition and low 1/f noise.

We have fabricated and measured the performance of antenna-coupled microbolometers (Nahum et al. 1991(a) based on the resistive transition of a high- T_c superconducting film for use as detectors of far-infrared and millimeter waves. A planar lithographed antenna (log-periodic or log-spiral) is used to couple the radiation to a thin YBCO film with dimensions $\approx 6\times13 \,\mu\text{m}^2$, which are much smaller than the wavelength to be measured. This film acts both as the resistor to thermalize the RF currents and as a transition edge thermometer to measure the resulting temperature rise. Because of its small size, both the thermal conductance from the film into the bulk of the substrate and the heat capacity of the thermally active region are small. Consequently, the microbolometer has low noise, fast response and a high voltage responsivity. We have measured a phonon noise-limited electrical NEP of $4.5\times10^{-12}\text{WHz}^{-1/2}$ at 10 kHz modulation frequency and a responsivity of 478 V/W at a bias of 550 μ A. Measurements of the optical efficiency are in progress.

We discuss the design of high-T_c superconducting bolometers for applications such as infrared imaging arrays (Verghese et al. 1991(b)). The dependence of bolometer sensitivity on

Ų

excess voltage noise in the thermometer is a function of the detector area and thus of the wavelength to be detected. We use measurements of the voltage noise in thin films of YBa₂Cu₃O₇ on Si, Si₃N₄, and sapphire substrates to predict the performance of different bolometer architectures. Useful opportunities exist for bolometers made on both Si and Si₃N₄ membranes. We also describe a readout scheme for two-dimensional arrays of bolometers in which real-time signal integration is performed on chip.

Acknowledgments

This work was supported in part by the Director, Office of Energy Research, Office of Basic Energy Sciences, Materials Sciences Division of the U.S. Department of Energy under Contract No. DE-AC03-76SF00098.

References

Hu Q and Richards PL 1989 Appl. Phys. Lett. 55, 2444

Nahum M, Hu Q, Richards PL, Newman N, Sachtjen SA and Cole BF, 1991(a) IEEE Trans. Magn. MAG 27, 3081

Nahum M, Verghese S, Richards PL and Char K 1991(b) Appl. Phys. Lett. (to be published)

Richards PL, Clarke J, Leoni R, Lerch Ph, Verghese S, Beasley MR, Geballe TH, Hammond RH, Rosenthal P, and Spielman SR 1989 Appl. Phys. Lett. 54, 283

Verghese S, Richards PL, Char K, and Sachtjen SA 1990 SPIE Conf. Proc. 1292, 137

Verghese S, Richards PL, Char K, and Sachtjen SA, 1991(a) IEEE Trans. Magn. MAG 27, 3077

Verghese S, Richards PL, Char K, Fork DK and GeballeTH 1991(b) J. Appl. Phys. (to be published)

LAWRENCE BERKEŁEY LABORATORY CENTER FOR ADVANCED MATERIALS 1 CYCLOTRON ROAD BERKELEY, CALIFORNIA 94720